

Notice of References Cited	Application/Control No. 10/682,111	Applicant(s)/Patent Under Reexamination ONO ET AL.	
	Examiner George C. Eckert II	Art Unit 2815	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-4,893,160	01-1990	Blanchard, Richard A.	257/334
	B	US-5,674,766	10-1997	Darwish et al.	438/270
	C	US-5,821,583	10-1998	Hshieh et al.	257/330
	D	US-5,929,481	07-1999	Hshieh et al.	257/328
	E	US-6,008,520	12-1999	Darwish et al.	257/330
	F	US-6,160,288	12-2000	Yamada, Manabu	257/330
	G	US-6,262,453 B1	07-2001	Hshieh, Fwu-luan	257/341
	H	US-6,600,193 B2	07-2003	Darwish, Mohamed N.	257/330
	I	US-6,657,254 B2	12-2003	Hshieh et al.	257/330
	J	US-2003/0235959 A1	12-2003	Lichtenberger et al.	438/272
	K	US-2004/0070028 A1	04-2004	Azam et al.	257/330
	L	US-6,781,200 B2	08-2004	Ishimura et al.	257/330
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.